

**Search Notes**

Application/Control No.

10/827,375

Examiner

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Applicant(s)/Patent under  
Reexamination

LIANG ET AL.

Art Unit

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	592.1 602.1 605 606 846	7/18/2006	PK
216	39, 41		
336	65,83 200		
	206-208		
	220-223		
	232		
257	531		
438	238 381		
	106 107		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed Parent Application 10/200,194 (US PAT. 6,876,285)	7/18/2006	PK
Text Search EAST/NPL (IEEE)	7/18/2006	PK